

### N-Channel Super Junction Power MOSFET $\, \mathrm{I\!V}$

#### **General Description**

The series of devices use advanced trench gate super junction technology and design to provide ultra-low Rds(ON) and low gate charge and With a rapid recovery body diode. This super junction MOSFET fits the industry's AC-DC SMPS requirements for PFC, AC/DC power conversion, industrial power applications, Fast charger, new energy vehicle charging pile, on-board OBC etc.

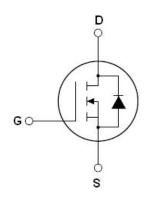
F	ea	tu	ire	9

- New technology for high voltage device
- Ultra low on-resistance and ultra low conduction losses
- Ultra Low Gate Charge cause lower driving requirements
- Diode reverse recovery speed is super fast
- High reliability
- ROHS compliant& Halogen Free

#### **Application**

- Power factor correction (PFC)
- Switched mode power supplies(SMPS)
- Uninterruptible Power Supply (UPS)
- On-board charger(OBC)

V <sub>DS min@Tjmax</sub>	710	V
R <sub>DS(ON)TYP</sub>	110	mΩ
ID	26	Α
Qg	41	nC

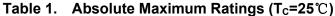


Schematic diagram

♦ Intrinsic fast-recovery body diode

#### **Package Marking And Ordering Information**

Device	Device Package	Marking	
NCE65NF130F	TO-220F-3L	NCE65NF130F	





TO-220F

V1.0

Parameter	Symbol	Value	Unit
Drain-Source Voltage (V <sub>GS</sub> =0V)	VDS	650	V
Gate-Source Voltage (V <sub>DS</sub> =0V) AC (f>1 Hz)	Vgs	±30	V
Gate-Source Voltage (VDS=0V) DC	V <sub>G</sub> S	±20	V
Continuous Drain Current at Tc=25°C	I <sub>D (DC)</sub>	26	А
Continuous Drain Current at Tc=100°C	I <sub>D (DC)</sub>	18.2	А
Pulsed drain current (Note 1)	I <sub>DM (pluse)</sub>	78	А
Maximum Power Dissipation(Tc=25℃)	P <sub>D</sub>	34.5	W
Derate above 25°C		0.23	W/°C
Avalanche current <sup>(Note 1)</sup>	I <sub>AS</sub>	7	А
Drain Source voltage slope, V <sub>DS</sub> ≤480 V,	dv/dt	50	V/ns
Reverse diode dv/dt, $V_{DS} \leq 480 \text{ V,I}_{SD} < I_{D}$	dv/dt	50	V/ns
Operating Junction and Storage Temperature Range	T <sub>J</sub> ,T <sub>STG</sub>	-55+175	°C

<sup>\*</sup> limited by maximum junction temperature

V1.0



#### Table 2. Thermal Characteristic

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case (Maximum)	R <sub>thJC</sub>	4.34	°C /W
Thermal Resistance, Junction-to-Ambient (Maximum)	R <sub>thJA</sub>	62	°C /W

Table 3. Electrical Characteristics (TA=25℃unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
On/off states						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V I <sub>D</sub> =250uA	650			V
Zero Gate Voltage Drain Current(Tc=25℃)	I <sub>DSS</sub>	V <sub>DS</sub> =650V,V <sub>GS</sub> =0V			10	μA
Zero Gate Voltage Drain Current(Tc=125℃)	I <sub>DSS</sub>	V <sub>DS</sub> =650V,V <sub>GS</sub> =0V			400	μA
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±20V,V <sub>DS</sub> =0V			±100	nA
Gate Threshold Voltage	$V_{GS(th)}$	V <sub>DS</sub> =V <sub>GS</sub> ,I <sub>D</sub> =500uA	3.5	4.2	5.0	V
Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =13A		110	130	mΩ
Dynamic Characteristics						
Input Capacitance	C <sub>lss</sub>			2161		pF
Output Capacitance	Coss	$V_{DS}$ =50V, $V_{GS}$ =0V, F=1.0MHz		95		pF
Reverse Transfer Capacitance	C <sub>rss</sub>	F=1.UIVIHZ		50		pF
Total Gate Charge	Qg			41.2		nC
Gate-Source Charge	$Q_{\mathrm{gs}}$	V <sub>DS</sub> =480V,I <sub>D</sub> =13A,		16.3		nC
Gate-Drain Charge	$Q_{gd}$	V <sub>GS</sub> =10V		12.8		nC
Gate plateau voltage	Vgp			7.0		V
Intrinsic gate resistance	R <sub>G</sub>	f = 1 MHz open drain		1.5		Ω
Switching times						
Turn-on Delay Time	t <sub>d(on)</sub>			43		nS
Turn-on Rise Time	t <sub>r</sub>	V <sub>DD</sub> =380V,I <sub>D</sub> =13A,		16		nS
Turn-Off Delay Time	t <sub>d(off)</sub>	$R_G=1.7\Omega, V_{GS}=10V$		93		nS
Turn-Off Fall Time	t <sub>f</sub>			20		nS
Source- Drain Diode Characteristics						
Source-drain current(Body Diode)	I <sub>SD</sub>	T -05°C			26	Α
Pulsed Source-drain current(Body Diode)	I <sub>SDM</sub>	T <sub>C</sub> =25°C			78	Α
Forward On Voltage	V <sub>SD</sub>	Tj=25°C,I <sub>SD</sub> =26A,V <sub>GS</sub> =0V		1.0	1.2	V
Reverse Recovery Time	t <sub>rr</sub>	Tj=25°C,I <sub>F</sub> =13A,di/dt=100A/μs		145		nS
Reverse Recovery Charge	Qrr			0.725		uC
Peak Reverse Recovery Current	I <sub>rrm</sub>			10		Α

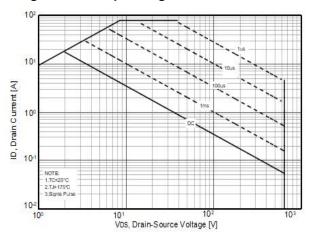
Notes 1.Repetitive Rating: Pulse width limited by maximum junction temperature

<sup>2.</sup> Tj=25 $^{\circ}$ C,VDD=50V,VG=10V, R<sub>G</sub>=25 $\Omega$ 



#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS (curves)

Figure 1. Safe operating area



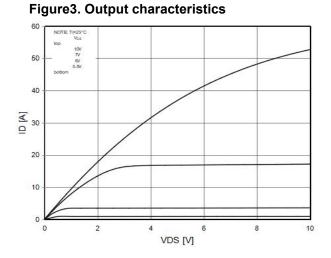


Figure 5. Static drain-source on resistance

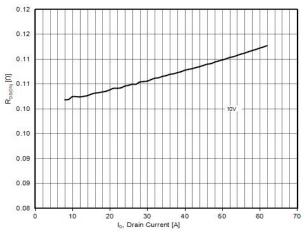


Figure 2. Capacitance

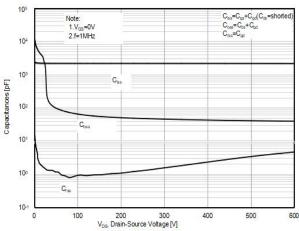


Figure 4. Source-Drain Diode Forward Voltage

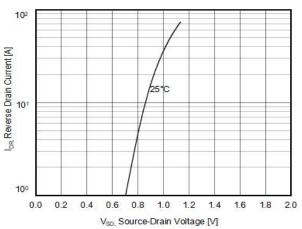
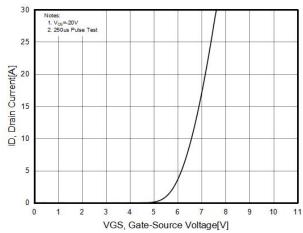


Figure 6. Transfer characteristics



V1.0



Figure 7. R<sub>DS(ON)</sub> vs Junction Temperature

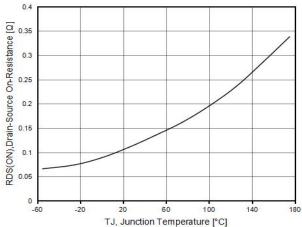


Figure 9. Gate charge waveforms

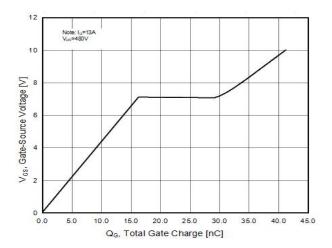


Figure8. BV<sub>DSS</sub> vs Junction Temperature

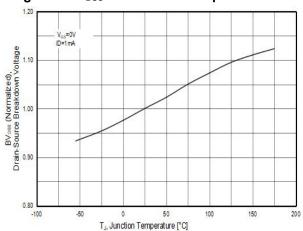
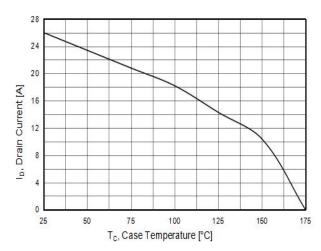


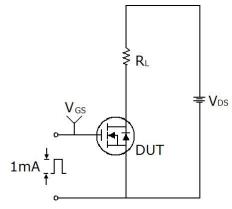
Figure 10. Maximum I<sub>D</sub> vs Junction Temperature

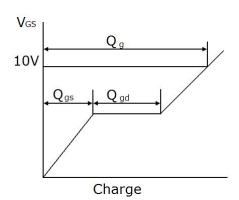




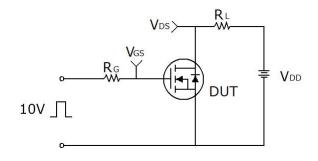
## **Test circuit**

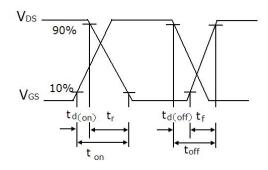
#### 1) Gate charge test circuit & Waveform



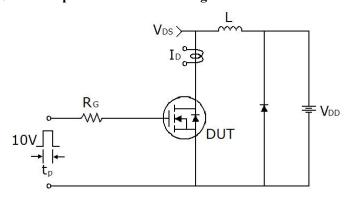


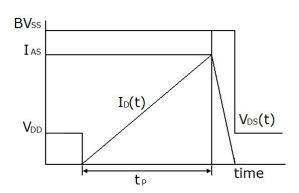
#### 2) Switch Time Test Circuit:





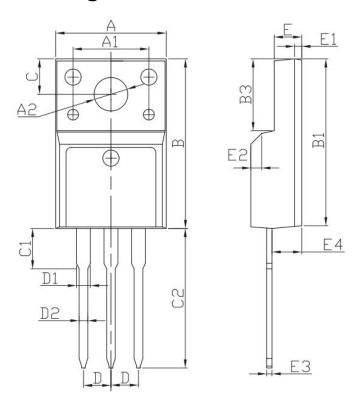
### 3) Unclamped Inductive Switching Test Circuit & Waveforms







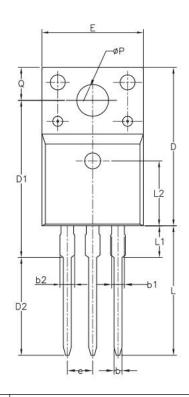
# **TO-220F-3L-L Package Information**

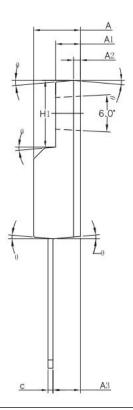


Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
А	9.86	10.46	0.387	0.411
A1	6.80	7.20	0.267	0.283
A2	2.92	3.32	0.115	0.130
A3	9.40	10.00	0.369	0.393
В	15.40	16.40	0.605	0.644
B1	15.10	16.10	0.593	0.633
B2	4.40	5.00	0.173	0.196
В3	6.40	7.00	0.251	0.275
С	3.05	3.55	0.120	0.139
C1	2.95	3.55	0.116	0.139
C2	28.20	29.20	1.108	1.147
D	2.54	BSC	0.100 BSC	
D1		1.47		0.058
D2	0.60	1.00	0.024	0.039
E	2.30	2.80	0.090	0.110
E1	0.45	0.95	0.018	0.037
E2	45.0°		45.00°	
E3	0.30	0.70	0.012	0.028
E4	2.45	3.05	0.096	0.120



# **TO-220F-3L-P Package Information**





Symbol	Dimensions	Dimensions In Millimeters		s In Inches
	Min.	Max.	Min.	Max.
А	4.50	4.83	0.177	0.190
A1	2.34	2.74	0.092	0.108
A2	0.70	) REF	0.028 REF	
A3	2.56	2.93	0.101	0.115
b	0.70	0.90	0.028	0.035
b1	1.18	1.38	0.046	0.054
b2	-	1.47		0.058
С	0.45	0.60	0.018	0.024
D	15.67	16.07	0.616	0.631
D1	15.55	15.95	0.611	0.627
D2	9.60	10.00	0.377	0.393
E	9.96	10.36	0.391	0.407
е	2.54	BSC	0.100 BSC	
H1	6.48	6.88	0.255	0.270
L	12.68	13.28	0.498	0.522
L1	-	3.50		0.138
L2	6.50	6.50 REF		5 REF
Ø P	3.08	3.28	0.121	0.129
Q	3.20	3.40	0.126	0.134



#### ATTENTION:

- Any and all NCE products described or contained herein do not have specifications that can handle applications that require extremely high levels of reliability, such as life-support systems, aircraft's control systems, or other applications whose failure can be reasonably expected to result in serious physical and/or material damage. Consult with your NCE representative nearest you before using any NCE products described or contained herein in such applications.
- NCE assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all NCE products described or contained herein.
- Specifications of any and all NCE products described or contained herein stipulate the performance, characteristics, and functions of the described products in the independent state, and are not guarantees of the performance, characteristics, and functions of the described products as mounted in the customer's products or equipment. To verify symptoms and states that cannot be evaluated in an independent device, the customer should always evaluate and test devices mounted in the customer's products or equipment.
- NCE Power Semiconductor CO.,LTD. strives to supply high-quality high-reliability products. However, any and all semiconductor products fail with some probability. It is possible that these probabilistic failures could give rise to accidents or events that could endanger human lives, that could give rise to smoke or fire, or that could cause damage to other property. When designing equipment, adopt safety measures so that these kinds of accidents or events cannot occur. Such measures include but are not limited to protective circuits and error prevention circuits for safe design, redundant design, and structural design.
- In the event that any or all NCE products(including technical data, services) described or contained herein are controlled under any of applicable local export control laws and regulations, such products must not be exported without obtaining the export license from the authorities concerned in accordance with the above law.
- No part of this publication may be reproduced or transmitted in any form or by any means, electronic or mechanical, including photocopying and recording, or any information storage or retrieval system, or otherwise, without the prior written permission of NCE Power Semiconductor CO.,LTD.
- Information (including circuit diagrams and circuit parameters) herein is for example only; it is not guaranteed for volume production. NCE believes information herein is accurate and reliable, but no guarantees are made or implied regarding its use or any infringements of intellectual property rights or other rights of third parties.
- Any and all information described or contained herein are subject to change without notice due to product/technology improvement, etc. When designing equipment, refer to the "Delivery Specification" for the NCE product that you intend to use.
- This catalog provides information as of Mar. 2010. Specifications and information herein are subject to change without notice.

V1.0